

Notice of References Cited	Application/Control No. 10/672,010	Applicant(s)/Patent Under Reexamination SHIBUYA ET AL.	
	Examiner Alex Liew	Art Unit 2624	Page 1 of 1

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*	C	US-7,016,526	03-2006	Smilansky et al.	382/149
*	D	US-6,408,105	06-2002	Maruo, Kazuyuki	382/281
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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